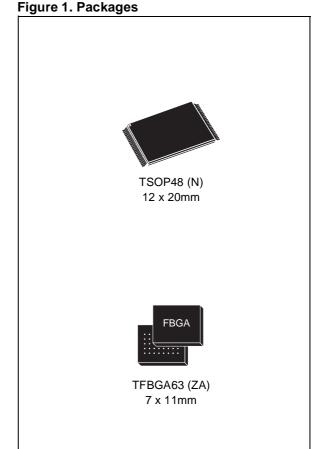


64 Mbit (4Mb x16, Uniform Block) 3V Supply Flash Memory

PRODUCT PREVIEW

FEATURES SUMMARY

- SUPPLY VOLTAGE
 - V_{CC} = 2.7V to 3.6V Core Power Supply
 - V_{CCQ} = 1.8V to 3.6V for Input/Output
 - V_{PP} =12 V for Fast Program (optional)
- ACCESS TIME: 70, 90, 100 and 120ns
- PROGRAMMING TIME
 - 10 µs typical
 - Double Word Program option
- 128 UNIFORM, 32-KWord MEMORY BLOCKS
- PROGRAM/ERASE CONTROLLER
 - Embedded Program and Erase algorithms
- ERASE SUSPEND and RESUME MODES
 - Read and Program another Block during Erase Suspend
- UNLOCK BYPASS PROGRAM COMMAND
 - Faster Production/Batch Programming
- WRITE PROTECT OPTIONS
- M29W641DH: WP Pin for Write Protection of Highest Address Block
- M29W641DL: WP Pin for Write Protection of Lowest Address Block
- M29W641DU: No Write Protection
- TEMPORARY BLOCK UNPROTECTION MODE
- COMMON FLASH INTERFACE
- EXTENDED MEMORY BLOCK
 - Extra block used as security block or to store additional information
- LOW POWER CONSUMPTION
 - Standby and Automatic Standby
- ELECTRONIC SIGNATURE
 - Manufacturer Code: 0020h
 - Device Code M29W641D: 22C7h



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SUMMARY DESCRIPTION

The M29W641D is a 64 Mbit (4Mb x16) non-volatile memory that can be read, erased and reprogrammed. These operations can be performed using a single, low voltage, 2.7V to 3.6V V_{CC} supply for the circuitry and a 1.8V to 3.6V V_{CCQ} supply for the Input/Output pins. An optional 12 V V_{PP} power supply is provided to speed up customer programming.

On power-up the memory defaults to its Read mode where it can be read in the same way as a ROM or EPROM.

The highest address block of the M29W641DH or the lowest address block of the M29W641DL can be protected from accidental programming or erasure using the \overline{WP} pin (if $\overline{WP} = V_{IL}$). The M29W641DU does not feature the \overline{WP} pin.

Each block can be erased independently so it is possible to preserve valid data while old data is erased. The blocks can be protected to prevent accidental Program or Erase commands from modifying the memory. Program and Erase commands are written to the Command Interface of the memory. An on-chip Program/Erase Controller simplifies the process of programming or erasing the memory by taking care of all of the special operations that are required to update the memory contents. The end of a program or erase operation can be detected and any error conditions identified. The command set required to control the memory is consistent with JEDEC standards.

The M29W641D has an extra block, the Extended Block, (of 32 KWords) that can be accessed using a dedicated command. The Extended Block can be protected and so is useful for storing security information. However the protection is not reversible, once protected the protection cannot be undone.

Chip Enable, Output Enable and Write Enable signals control the bus operation of the memory. They allow simple connection to most microprocessors, often without additional logic.

The memory is offered in a 48-pin TSOP package (M29W641DL and M29W641DH) or in a 63-ball TF-BGA package (M29W641DU). All devices are delivered with all the bits erased (set to 1).

Figure 2. Logic Diagram

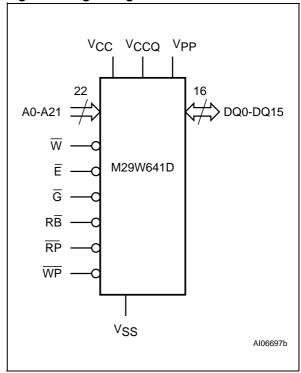
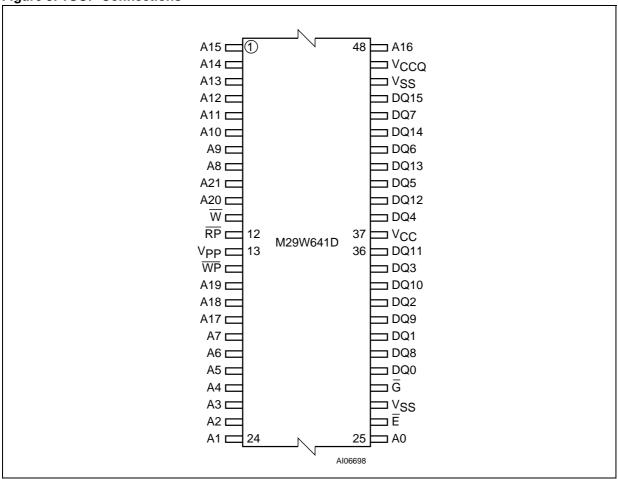


Table 1. Signal Names

A0-A21	Address Inputs
DQ0-DQ7	Data Inputs/Outputs
DQ8- DQ15	Data Inputs/Outputs
Ē	Chip Enable
G	Output Enable
W	Write Enable
RP	Reset/Block Temporary Unprotect (M29W641DH and M29W641DL only)
RB̄	Ready/Busy Output (M29W641DU only)
WP	Write Protect
Vcc	Supply Voltage
Vccq	Supply Voltage for Input/Output
V _{PP}	Supply Voltage for Fast Program (optional)
V _{SS}	Ground

Figure 3. TSOP Connections



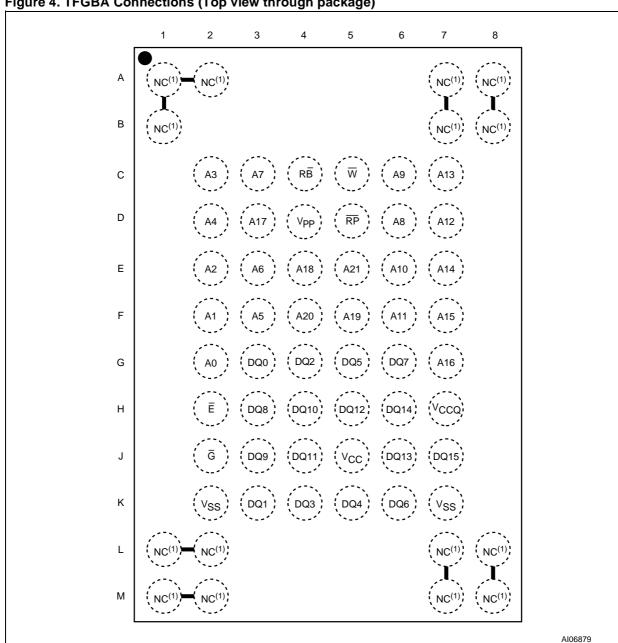


Figure 4. TFGBA Connections (Top view through package)

Note: 1. Balls are shorted together via the substrate but not connected to the die.

///

SIGNAL DESCRIPTIONS

See Figure 2, Logic Diagram, and Table 1, Signal Names, for a brief overview of the signals connected to this device.

Address Inputs (A0-A21). The Address Inputs select the cells in the memory array to access during Bus Read operations. During Bus Write operations they control the commands sent to the Command Interface of the Program/Erase Controller.

Data Inputs/Outputs (DQ0-DQ7). The Data I/O outputs the data stored at the selected address during a Bus Read operation. During Bus Write operations they represent the commands sent to the Command Interface of the Program/Erase Controller.

Data Inputs/Outputs (DQ8-DQ15). The Data I/O outputs the data stored at the selected address during a Bus Read operation. During Bus Write operations the Command Register does not use these bits. When reading the Status Register these bits should be ignored.

Chip Enable (\overline{\mathbf{E}}). The Chip Enable, $\overline{\mathbf{E}}$, activates the memory, allowing Bus Read and Bus Write operations to be performed. When Chip Enable is High, V_{IH} , all other pins are ignored.

Output Enable (\overline{G}) . The Output Enable, \overline{G} , controls the Bus Read operation of the memory.

Write Enable (\overline{W}). The Write Enable, \overline{W} , controls the Bus Write operation of the memory's Command Interface.

Write Protect (WP). The Write Protect pin is available in the M29W641DH and M29W641DL only. It provides a hardware method of protecting the highest address block for the M29W641DH and the lowest address block for the M29W641DL. The Write Protect pin must not be left floating or unconnected.

When Write Protect is Low, V_{IL} , the memory protects either the highest or lowest address block; Program and Erase operations in this block are ignored while Write Protect is Low.

When Write Protect is High, V_{IH} , the memory reverts to the previous protection status for this block. Program and Erase operations can now modify the data in this block unless the block is protected using Block Protection.

Ready/Busy Output (RB). The Ready/Busy pin is an open-drain output that can be used to identify when the device is performing a Program or Erase operation. During Program or Erase operations Ready/Busy is Low, Vol. Ready/Busy is high-impedance during Read mode, Auto Select mode and Erase Suspend mode.

After a Hardware Reset, Bus Read and Bus Write operations cannot begin until Ready/Busy be-

comes high-impedance. See Table 13 and Figure 12, Reset/Block Temporary Unprotect AC Characteristics.

The use of an open-drain output allows the Ready/ Busy pins from several memories to be connected to a single pull-up resistor. A Low will then indicate that one, or more, of the memories is busy.

Reset/Block Temporary Unprotect (RP). The Reset/Block Temporary Unprotect pin can be used to apply a Hardware Reset to the memory or to temporarily unprotect all Blocks that have been protected.

Note that if Write Protect (\overline{WP}) is at V_{IL} , then one of the two outermost blocks will remain protected even if RP is at V_{ID} .

A Hardware Reset is achieved by holding Reset/Block Temporary Unprotect Low, V_{IL} , for at least t_{PLPX} . After Reset/Block Temporary Unprotect goes High, V_{IH} , the memory will be ready for Bus Read and Bus Write operations after t_{PHEL} or t_{RHEL} , whichever occurs last. See Table 13 and Figure 12, Reset/Block Temporary Unprotect AC Characteristics, for more details.

Holding \overline{RP} at V_{ID} will temporarily unprotect the protected Blocks in the memory. Program and Erase operations on all blocks will be possible. The transition from V_{IH} to V_{ID} must be slower than tehenh.

 V_{PP} (V_{PP}). When the V_{PP} pin is raised to V_{PPH} the memory automatically enters the Unlock Bypass mode. When the pin is returned to V_{IH} or V_{IL} normal operation resumes. During Unlock Bypass Program operations the memory draws I_{PP} from the pin to supply the programming circuits. See the description of the Unlock Bypass command in the Command Interface section. The transitions from V_{IH} to V_{PP} and from V_{PP} to V_{IH} must be slower than t_{VHVPP} , see Figure 13.

Never raise the pin to V_{PP} from any mode except Read mode, otherwise the memory may be left in an indeterminate state.

 V_{CC} Supply Voltage (2.7V to 3.6V). V_{CC} provides the power supply for all operations (Read, Program and Erase).

The Command Interface is disabled when the V_{CC} Supply Voltage is less than the Lockout Voltage, V_{LKO} . This prevents Bus Write operations from accidentally damaging the data during power up, power down and power surges. If the Program/ Erase Controller is programming or erasing during this time then the operation aborts and the memory contents being altered will be invalid.

 V_{CCQ} Supply Voltage (1.8V to 3.6V). V_{CCQ} provides the power supply to the I/O pins and enables all Outputs to be powered independently of V_{CC} .

 V_{CCQ} can be tied to V_{CC} or can use a separate supply.

 $\rm \textbf{V}_{SS}$ Ground. $\rm V_{SS}$ is the reference for all voltage measurements. The device features two $\rm V_{SS}$ pins which must be both connected to the system ground.

Note: Each device in a system should have V_{CC} , V_{CCQ} and V_{PP} decoupled from V_{SS} with a

 $0.1\mu F$ ceramic capacitor close to the pin for current surge protection (high frequency, inherently low inductance capacitors should be as close as possible to the device). See Figure 8, AC Measurement Load Circuit. The PCB trace widths should be sufficient to carry the required V_{PP} program and erase currents. See Table 9, DC Characteristics.

Table 2. Bus Operations

Operation	Ē	G	w	Address Inputs A0-A21	Data Inputs/Outputs DQ15-DQ0
Bus Read	V _{IL}	V _{IL}	V _{IH}	Cell Address	Data Output
Bus Write	V _{IL}	V _{IH}	V _{IL}	Command Address	Data Input
Output Disable	Х	V _{IH}	ViH	Х	Hi-Z
Standby	V _{IH}	Х	Х	Х	Hi-Z
Read Manufacturer Code	V _{IL}	V _{IL}	V _{IH}	$ A0 = V_{IL}, A1 = V_{IL}, A9 = V_{ID}, \\ Others V_{IL} \ or \ V_{IH} $	0020h
Read Device Code	VIL	VIL	V _{IH}	$ \begin{array}{l} A0 = V_{IH}, \ A1 = V_{IL}, \ A9 = V_{ID}, \\ Others \ V_{IL} \ or \ V_{IH} \end{array} $	22C7h
Extended Memory Block Verify Code	VIL	VIL	ViH	$A0 = V_{IH}$, $A1 = V_{IH}$, $A6 = V_{IL}$, $A9 = V_{ID}$, Others V_{IL} or V_{IH}	98h (factory locked, WP protects highest address block) 18h (not factory locked, WP protects highest address block) 88h (factory locked, WP protects lowest block) 08h (not factory locked, WP protects lowest block)

Note: $X = V_{IL}$ or V_{IH} .

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BUS OPERATIONS

There are five standard bus operations that control the device. These are Bus Read, Bus Write, Output Disable, Standby and Automatic Standby. See Table 2, Bus Operations, for a summary. Typically glitches of less than 5ns on Chip Enable or Write Enable are ignored by the memory and do not affect bus operations.

Bus Read. Bus Read operations read from the memory cells, or specific registers in the Command Interface. A valid Bus Read operation involves setting the desired address on the Address Inputs, applying a Low signal, V_{IL} , to Chip Enable and Output Enable and keeping Write Enable High, V_{IH} . The Data Inputs/Outputs will output the value, see Figure 9, Read Mode AC Waveforms, and Table 10, Read AC Characteristics, for details of when the output becomes valid.

Bus Write. Bus Write operations write to the Command Interface. A valid Bus Write operation begins by setting the desired address on the Address Inputs. The Address Inputs are latched by the Command Interface on the falling edge of Chip Enable or Write Enable, whichever occurs last. The Data Inputs/Outputs are latched by the Command Interface on the rising edge of Chip Enable or Write Enable, whichever occurs first. Output Enable must remain High, V_{IH}, during the whole Bus Write operation. See Figure 10 and Figure 11, Write AC Waveforms, and Table 11 and Table 12, Write AC Characteristics, for details of the timing requirements.

Output Disable. The Data Inputs/Outputs are in the high impedance state when Output Enable is High, V_{IH} .

Standby. When Chip Enable is High, V_{IH} , the memory enters Standby mode and the Data Inputs/Outputs pins are placed in the high-impedance state. To reduce the Supply Current to the Standby Supply Current, I_{CC2} , Chip Enable should

be held within $V_{CC} \pm 0.2V$. For the Standby current level see Table 9, DC Characteristics.

During program or erase operations the memory will continue to use the Program/Erase Supply Current, I_{CC3}, for Program or Erase operations until the operation completes.

Automatic Standby. If CMOS levels ($V_{CC} \pm 0.2V$) are used to drive the bus and the bus is inactive for 300ns or more the memory enters Automatic Standby where the internal Supply Current is reduced to the Standby Supply Current, I_{CC2} . The Data Inputs/Outputs will still output data if a Bus Read operation is in progress.

Special Bus Operations

Additional bus operations can be performed to read the Electronic Signature and also to apply and remove Block Protection. These bus operations are intended for use by programming equipment and are not usually used in applications. They require V_{ID} to be applied to some pins.

Electronic Signature. The memory has two codes, the manufacturer code and the device code, that can be read to identify the memory. These codes can be read by applying the signals listed in Table 2, Bus Operations.

Block Protect and Chip Unprotect. Groups of blocks can be protected against accidental Program or Erase. The whole chip can be unprotected to allow the data inside the blocks to be changed.

Write Protect (\overline{WP}) can be used to protect one of the outermost blocks. When Write Protect (\overline{WP}) is at V_{IL} one of the two outermost blocks is protected and remains protected regardless of the Block Protection Status or the Reset/Block Temporary Unprotect pin status. For the M29W641DH, it is the highest addressed block that can be protected. For the M29W641DL, it is the lowest.

Block Protect and Chip Unprotect operations are described in Appendix D.

COMMAND INTERFACE

All Bus Write operations to the memory are interpreted by the Command Interface. Commands consist of one or more sequential Bus Write operations. Failure to observe a valid sequence of Bus Write operations will result in the memory returning to Read mode. The long command sequences are imposed to maximize data security.

See Table 3 for a summary of the commands.

Read/Reset Command

The Read/Reset command returns the memory to its Read mode where it behaves like a ROM or EPROM. It also resets the errors in the Status Register. Either one or three Bus Write operations can be used to issue the Read/Reset command.

The Read/Reset command can be issued, between Bus Write cycles before the start of a program or erase operation, to return the device to read mode. If the Read/Reset command is issued during the timeout of a Block erase operation then the memory will take up to 10µs to abort. During the abort period no valid data can be read from the memory. The Read/Reset command will not abort an Erase operation when issued while in Erase Suspend.

Auto Select Command

The Auto Select command is used to read the Manufacturer Code, the Device Code, the Block Protection Status and the Extended Memory Block Verify Code. Three consecutive Bus Write operations are required to issue the Auto Select command. Once the Auto Select command is issued the memory remains in Auto Select mode until a Read/Reset command is issued. Read CFI Query and Read/Reset commands are accepted in Auto Select mode, all other commands are ignored.

In Auto Select mode the Manufacturer Code can be read using a Bus Read operation with A0 = V_{IL} and A1 = V_{IL} . The other address bits may be set to either V_{IL} or V_{IH} . The Manufacturer Code for ST-Microelectronics is 0020h.

The Device Code can be read using a Bus Read operation with $A0 = V_{IH}$ and $A1 = V_{IL}$. The other address bits may be set to either V_{IL} or V_{IH} . The Device Code for the M29W641D is 22C7h.

The Block Protection Status of each block can be read using a Bus Read operation with $A0 = V_{IL}$, $A1 = V_{IH}$, and A12-A21 specifying the address of the block. The other address bits may be set to either V_{IL} or V_{IH} . If the addressed block is protected then 01h is output on Data Inputs/Outputs DQ0-DQ7, otherwise 00h is output.

Read CFI Query Command

The Read CFI Query Command is used to read data from the Common Flash Interface (CFI) Memory Area. This command is valid when the de-

vice is in the Read Array mode, or when the device is in Autoselected mode.

One Bus Write cycle is required to issue the Read CFI Query Command. Once the command is issued subsequent Bus Read operations read from the Common Flash Interface Memory Area.

The Read/Reset command must be issued to return the device to the previous mode (the Read Array mode or Autoselected mode). A second Read/Reset command would be needed if the device is to be put in the Read Array mode from Autoselected mode.

See Appendix B, Table 18 to Table 23 for details on the information contained in the Common Flash Interface (CFI) memory area.

Program Command

The Program command can be used to program a value to one address in the memory array at a time. The command requires four Bus Write operations, the final write operation latches the address and data, and starts the Program/Erase Controller.

If the address falls in a protected block then the Program command is ignored, the data remains unchanged. The Status Register is never read and no error condition is given.

During the program operation the memory will ignore all commands. It is not possible to issue any command to abort or pause the operation. Typical program times are given in Table 4. Bus Read operations during the program operation will output the Status Register on the Data Inputs/Outputs. See the section on the Status Register for more details.

After the program operation has completed the memory will return to the Read mode, unless an error has occurred. When an error occurs the memory will continue to output the Status Register. A Read/Reset command must be issued to reset the error condition and return to Read mode.

Note that the Program command cannot change a bit set at '0' back to '1'. One of the Erase Commands must be used to set all the bits in a block or in the whole memory from '0' to '1'.

Fast Program Commands

There is a Fast Program command available to improve the programming throughput, by writing several adjacent words or bytes in parallel: the Double Word Program command.

Double Word Program Command. The Double Word Program command is used to write a page of two adjacent words in parallel. The two words must differ only for the address A0.

Three bus write cycles are necessary to issue the Double Word Program command.

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- The first bus cycle sets up the Double Word Program Command.
- The second bus cycle latches the Address and the Data of the first word to be written.
- The third bus cycle latches the Address and the Data of the second word to be written and starts the Program/Erase Controller.

Only one bank can be programmed at any one time. The other bank must be in Read mode or Erase Suspend.

Programming should not be attempted when V_{PP} is not at V_{PPH} .

After programming has started, Bus Read operations in the Bank being programmed output the Status Register content, while Bus Read operations to the other Bank output the contents of the memory array.

After the program operation has completed the memory will return to the Read mode, unless an error has occurred. When an error occurs Bus Read operations to the Bank where the command was issued will continue to output the Status Register. A Read/Reset command must be issued to reset the error condition and return to Read mode.

Note that the Fast Program commands cannot change a bit set at '0' back to '1'. One of the Erase Commands must be used to set all the bits in a block or in the whole memory from '0' to '1'.

Typical Program times are given in Table 4, Program, Erase Times and Program, Erase Endurance Cycles.

Unlock Bypass Command

The Unlock Bypass command is used in conjunction with the Unlock Bypass Program command to program the memory faster than with the standard program commands. When the cycle time to the device is long (as with some EPROM programmers) considerable time saving can be made by using these commands. Three Bus Write operations are required to issue the Unlock Bypass command.

Once the Unlock Bypass command has been issued the memory enters Unlock Bypass mode. When in this mode the memory can be read as if in Read mode.

When V_{PPH} is applied to the V_{PP} pin the memory automatically enters the Unlock Bypass mode and the Unlock Bypass Program command can be issued immediately.

Unlock Bypass Program Command

The Unlock Bypass Program command can be used to program one address in the memory array at a time. The command requires two Bus Write operations, the final write operation latches the ad-

dress and data, and starts the Program/Erase Controller.

A Program operation initiated by issuing the Unlock Bypass Program command is identical to a Program operation initiated by issuing the Program command. It cannot be aborted and a Bus Read operation will output the Status Register. See the Program Command paragraph for further details.

Unlock Bypass Reset Command

The Unlock Bypass Reset command can be used to return to Read/Reset mode from Unlock Bypass Mode. Two Bus Write operations are required to issue the Unlock Bypass Reset command. Read/Reset command does not exit from Unlock Bypass Mode.

Chip Erase Command

The Chip Erase command can be used to erase the entire chip. Six Bus Write operations are required to issue the Chip Erase Command and start the Program/Erase Controller.

If any blocks are protected then these are ignored and all the other blocks are erased. If all of the blocks are protected the Chip Erase operation appears to start but will terminate within about $100\mu s$, leaving the data unchanged. No error condition is given when protected blocks are ignored.

During the erase operation the memory will ignore all commands, including the Erase Suspend command. It is not possible to issue any command to abort the operation. Typical chip erase times are given in Table 4. All Bus Read operations during the Chip Erase operation will output the Status Register on the Data Inputs/Outputs. See the section on the Status Register for more details.

After the Chip Erase operation has completed the memory will return to the Read Mode, unless an error has occurred. When an error occurs the memory will continue to output the Status Register. A Read/Reset command must be issued to reset the error condition and return to Read Mode.

The Chip Erase Command sets all of the bits in unprotected blocks of the memory to '1'. All previous data is lost.

Block Erase Command

The Block Erase command can be used to erase a list of one or more blocks. Six Bus Write operations are required to select the first block in the list. Each additional block in the list can be selected by repeating the sixth Bus Write operation using the address of the additional block. The Block Erase operation starts the Program/Erase Controller about 50µs after the last Bus Write operation. Once the Program/Erase Controller starts it is not possible to select any more blocks. Each additional block must therefore be selected within 50µs of

the lowest address block. The 50µs timer restarts when an additional block is selected. The Status Register can be read after the sixth Bus Write operation. See the Status Register section for details on how to identify if the Program/Erase Controller has started the Block Erase operation.

If any selected blocks are protected then these are ignored and all the other selected blocks are erased. If all of the selected blocks are protected the Block Erase operation appears to start but will terminate within about 100µs, leaving the data unchanged. No error condition is given when protected blocks are ignored.

During the Block Erase operation the memory will ignore all commands except the Erase Suspend command. Typical block erase times are given in Table 4. All Bus Read operations during the Block Erase operation will output the Status Register on the Data Inputs/Outputs. See the section on the Status Register for more details.

After the Block Erase operation has completed the memory will return to the Read Mode, unless an error has occurred. When an error occurs the memory will continue to output the Status Register. A Read/Reset command must be issued to reset the error condition and return to Read mode.

The Block Erase Command sets all of the bits in the unprotected selected blocks to '1'. All previous data in the selected blocks is lost.

Erase Suspend Command

The Erase Suspend Command may be used to temporarily suspend a Block Erase operation and return the memory to Read mode. The command requires one Bus Write operation.

The Program/Erase Controller will suspend within the Erase Suspend Latency time of the Erase Suspend Command being issued. Once the Program/ Erase Controller has stopped the memory will be set to Read mode and the Erase will be suspended. If the Erase Suspend command is issued during the period when the memory is waiting for an additional block (before the Program/Erase Controller starts) then the Erase is suspended immediately and will start immediately when the Erase Resume Command is issued. It is not possible to select any further blocks to erase after the Erase Resume.

During Erase Suspend it is possible to Read and Program cells in blocks that are not being erased; both Read and Program operations behave as normal on these blocks. If any attempt is made to program in a protected block or in the suspended

block then the Program command is ignored and the data remains unchanged. The Status Register is not read and no error condition is given. Reading from blocks that are being erased will output the Status Register.

It is also possible to issue the Auto Select, Read CFI Query and Unlock Bypass commands during an Erase Suspend. The Read/Reset command must be issued to return the device to Read Array mode before the Resume command will be accepted.

Erase Resume Command

The Erase Resume command must be used to restart the Program/Erase Controller after an Erase Suspend. The device must be in Read Array mode before the Resume command will be accepted. An erase can be suspended and resumed more than once.

Enter Extended Block Command

The device has an extra 32 KWord block (Extended Block) that can only be accessed using the Enter Extended Block command. Three Bus write cycles are required to issue the Extended Block command. Once the command has been issued the device enters Extended Block mode where all Bus Read or Write operations to the Boot Block addresses access the Extended Block. The Extended Block (with the same address as the Boot Blocks) cannot be erased, and can be treated as one-time programmable (OTP) memory. In Extended Block mode the Boot Blocks are not accessible

To exit from the Extended Block mode the Exit Extended Block command must be issued.

The Extended Block can be protected, however once protected the protection cannot be undone.

Exit Extended Block Command

The Exit Extended Block command is used to exit from the Extended Block mode and return the device to Read mode. Four Bus Write operations are required to issue the command.

Block Protect and Chip Unprotect Commands

Groups of blocks can be protected against accidental Program or Erase. The whole chip can be unprotected to allow the data inside the blocks to be changed.

Block Protect and Chip Unprotect operations are described in Appendix D.

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Table 3. Commands

	ے		Bus Write Operations										
Command	Length	1st		2nd		3rd		4th		5th		61	th
	Ľ	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data
Read/Reset	1	Х	F0										
Read/Reset	3	555	AA	2AA	55	Х	F0						
Auto Select	3	555	AA	2AA	55	555	90						
Program	4	555	AA	2AA	55	555	A0	PA	PD				
Double Word Program	3	555	50	PA0	PD0	PA1	PD1						
Unlock Bypass	3	555	AA	2AA	55	555	20						
Unlock Bypass Program	2	Х	A0	PA	PD								
Unlock Bypass Reset	2	Х	90	Х	00								
Chip Erase	6	555	AA	2AA	55	555	80	555	AA	2AA	55	555	10
Block Erase	6+	555	AA	2AA	55	555	80	555	AA	2AA	55	ВА	30
Erase Suspend	1	Х	В0										
Erase Resume	1	Х	30										
Read CFI Query	1	55	98										
Enter Extended Block	3	555	AA	2AA	55	555	88						
Exit Extended Block	4	555	AA	2AA	55	555	90	Х	00				

Note: X Don't Care, PA Program Address, PD Program Data, BA Any address in the Block. All values in the table are in hexadecimal.

Table 4. Program, Erase Times and Program, Erase Endurance Cycles

Parameter	Min	Typ ^(1, 2)	Max ⁽²⁾	Unit
Chip Erase		80	400 ⁽³⁾	s
Block Erase (32 KWords)		0.8	6 ⁽⁴⁾	s
Erase Suspend Latency Time			50 ⁽⁴⁾	μs
Program (Word)		10	200 ⁽³⁾	μs
Double Word Program		10	200 ⁽³⁾	μs
Chip Program (Word by Word)		40	200 ⁽³⁾	S
Chip Program (Double Word)		20	100 ⁽³⁾	S
Program/Erase Cycles (per Block)	100,000			cycles
Data Retention	20			years

Note: 1. Typical values measured at room temperature and nominal voltages.
2. Sampled, but not 100% tested.
3. Maximum value measured at worst case conditions for both temperature and V_{CC} after 100,00 program/erase cycles.

^{4.} Maximum value measured at worst case conditions for both temperature and V_{CC} .

STATUS REGISTER

Bus Read operations from any address always read the Status Register during Program and Erase operations. It is also read during Erase Suspend when an address within a block being erased is accessed.

The bits in the Status Register are summarized in Table 5, Status Register Bits.

Data Polling Bit (DQ7). The Data Polling Bit can be used to identify whether the Program/Erase Controller has successfully completed its operation or if it has responded to an Erase Suspend. The Data Polling Bit is output on DQ7 when the Status Register is read.

During Program operations the Data Polling Bit outputs the complement of the bit being programmed to DQ7. After successful completion of the Program operation the memory returns to Read mode and Bus Read operations from the address just programmed output DQ7, not its complement.

During Erase operations the Data Polling Bit outputs '0', the complement of the erased state of DQ7. After successful completion of the Erase operation the memory returns to Read Mode.

In Erase Suspend mode the Data Polling Bit will output a '1' during a Bus Read operation within a block being erased. The Data Polling Bit will change from a '0' to a '1' when the Program/Erase Controller has suspended the Erase operation.

Figure 5, Data Polling Flowchart, gives an example of how to use the Data Polling Bit. A Valid Address is the address being programmed or an address within the block being erased.

Toggle Bit (DQ6). The Toggle Bit can be used to identify whether the Program/Erase Controller has successfully completed its operation or if it has responded to an Erase Suspend. The Toggle Bit is output on DQ6 when the Status Register is read.

During Program and Erase operations the Toggle Bit changes from '0' to '1' to '0', etc., with successive Bus Read operations at any address. After successful completion of the operation the memory returns to Read mode.

During Erase Suspend mode the Toggle Bit will output when addressing a cell within a block being erased. The Toggle Bit will stop toggling when the Program/Erase Controller has suspended the Erase operation.

Figure 6, Data Toggle Flowchart, gives an example of how to use the Data Toggle Bit.

Error Bit (DQ5). The Error Bit can be used to identify errors detected by the Program/Erase Controller. The Error Bit is set to '1' when a Program, Block Erase or Chip Erase operation fails to write the correct data to the memory. If the Error Bit is set a Read/Reset command must be issued before other commands are issued. The Error bit is output on DQ5 when the Status Register is read.

Note that the Program command cannot change a bit set to '0' back to '1' and attempting to do so will set DQ5 to '1'. A Bus Read operation to that address will show the bit is still '0'. One of the Erase commands must be used to set all the bits in a block or in the whole memory from '0' to '1'.

Erase Timer Bit (DQ3). The Erase Timer Bit can be used to identify the start of Program/Erase Controller operation during a Block Erase command. Once the Program/Erase Controller starts erasing the Erase Timer Bit is set to '1'. Before the Program/Erase Controller starts the Erase Timer Bit is set to '0' and additional blocks to be erased may be written to the Command Interface. The Erase Timer Bit is output on DQ3 when the Status Register is read.

Alternative Toggle Bit (DQ2). The Alternative Toggle Bit can be used to monitor the Program/ Erase controller during Erase operations. The Alternative Toggle Bit is output on DQ2 when the Status Register is read.

During Chip Erase and Block Erase operations the Toggle Bit changes from '0' to '1' to '0', etc., with successive Bus Read operations from addresses within the blocks being erased. A protected block is treated the same as a block not being erased. Once the operation completes the memory returns to Read mode.

During Erase Suspend the Alternative Toggle Bit changes from '0' to '1' to '0', etc. with successive Bus Read operations from addresses within the blocks being erased. Bus Read operations to addresses within blocks not being erased will output the memory cell data as if in Read mode.

After an Erase operation that causes the Error Bit to be set the Alternative Toggle Bit can be used to identify which block or blocks have caused the error. The Alternative Toggle Bit changes from '0' to '1' to '0', etc. with successive Bus Read Operations from addresses within blocks that have not erased correctly. The Alternative Toggle Bit does not change if the addressed block has erased correctly.

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Table 5. Status Register Bits

Operation Address		DQ7	DQ6	DQ5	DQ3	DQ2	R B (1)
Program	Any Address	DQ7	Toggle	0	_	_	0
Program During Erase Suspend	Any Address	DQ7	Toggle	0	-	_	0
Program Error	Any Address	DQ7	Toggle	1	_	_	0
Chip Erase	Any Address	0	Toggle	0	1	Toggle	0
Block Erase before timeout	Erasing Block	0	Toggle	0	0	Toggle	0
	Non-Erasing Block	0	Toggle	0	0	No Toggle	0
	Erasing Block	0	Toggle	0	1	Toggle	0
Block Erase	Non-Erasing Block	0	Toggle	0	1	No Toggle	0
Erase Suspend	Erasing Block	1	No Toggle	0	1	Toggle	1
	Non-Erasing Block		Data ı	ead as n	ormal		1
Erase Error	Good Block Address	0	Toggle	1	1	No Toggle	0
	Faulty Block Address	0	Toggle	1	1	Toggle	0

Note: 1. Only the M29W641DU device is concerned.
2. Unspecified data bits should be ignored.

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Figure 5. Data Polling Flowchart

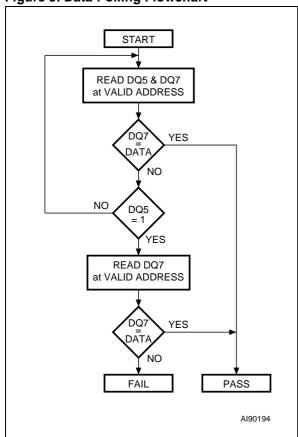
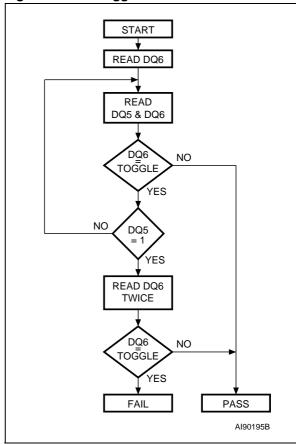


Figure 6. Data Toggle Flowchart



MAXIMUM RATING

Stressing the device above the rating listed in the Absolute Maximum Ratings table may cause permanent damage to the device. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 6. Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Unit
T _{BIAS}	Temperature Under Bias	-50	125	°C
T _{STG}	Storage Temperature		150	°C
V _{CCQ}	Input/Output Supply Voltage (1,2)	-0.6	4	V
Vcc	Supply Voltage	-0.6	4	V
V _{ID}	Identification Voltage	-0.6	13.5	V
V _{PP} ⁽³⁾	Program Voltage	-0.6	13.5	V

Note: 1. Minimum voltage may undershoot to -2V during transition and for less than 20ns during transitions.

2. Maximum voltage may overshoot to V_{CC} +2V during transition and for less than 20ns during transitions.

^{3.} V_{PP} must not remain at 12V for more than a total of 80hrs.

DC AND AC PARAMETERS

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC Characteristic tables that follow are derived from tests performed under the Measure-

ment Conditions summarized in the relevant tables. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters

Table 7. Operating and AC Measurement Conditions

	M29W641D										
Parameter	7	70		90		00	120		Unit		
	Min	Max	Min	Max	Min	Max	Min	Max			
V _{CC} Supply Voltage	3.0	3.6	2.7	3.6	3.0	3.6	2.7	3.6	V		
V _{CCQ} Supply Voltage	3.0	3.6	2.7	3.6	1.65	1.95	1.65	1.95	V		
Ambient Operating Temperature	-40	85	-40	85	-40	85	-40	85	°C		
Load Capacitance (C _L)	3	30 30		0	3	0	30		pF		
Input Rise and Fall Times		10		10		10		10	ns		
Input Pulse Voltages	0 to \	0 to V _{CCQ}		0 to V _{CCQ}		Vccq	0 to \	Vccq	0 to \	Vccq	V
Input and Output Timing Ref. Voltages	Vcc	V _{CCQ} /2		V _{CCQ} /2 V _{CCQ} /2		V _{CCQ} /2		V _{CCQ} /2		V	

Figure 7. AC Measurement I/O Waveform

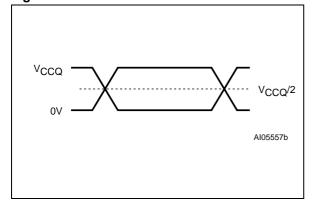


Figure 8. AC Measurement Load Circuit

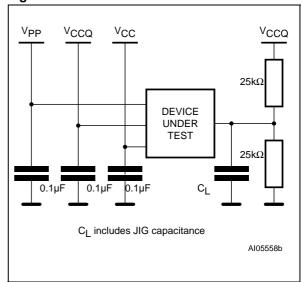


Table 8. Device Capacitance

Symbol	Parameter	Test Condition	Min	Max	Unit
C _{IN}	Input Capacitance	V _{IN} = 0V		6	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0V		12	pF

Note: Sampled only, not 100% tested.

Table 9. DC Characteristics

Symbol	Parameter	Test Cor	ndition	Min	Max	Unit
ILI	Input Leakage Current	0V ≤ V _{IN} :	≤ V _{CCQ}		±1	μΑ
I _{LO}	Output Leakage Current	0V ≤ V _{OUT}	· ≤ V _{CCQ}		±1	μA
Icc1	Supply Current (Read)	E = V _{IL} , G f = 6 M	** **		10	mA
I _{CC2}	Supply Current (Standby)	$\frac{\overline{E} = V_{CC}}{\overline{RP} = V_{CC}}$			100	μΑ
laas	Supply Current (Program/	Program/Erase	V _{PP} pin = V _{IL} or V _{IH}		20	mA
Icc3	Erase)	Controller active	V _{PP} pin = V _{PPH}		20	mA
V _{IL}	Input Low Voltage	V _{CCQ} ≤	V _C C	-0.5	0.8	V
V _{IH}	Input High Voltage	V _{CCQ} ≤	V _C C	0.7V _{CCQ}	V _{CCQ} + 0.3	V
V _{РРН}	Voltage for V _{PP} Program Acceleration	V _{CC} = 3.0	V ±10%	11.5	12.5	V
I _{PP}	Current for V _{PP} Program Acceleration	V _{CC} = 3.0	V ±10%		15	mA
V _{OL}	Output Low Voltage	I _{OL} = 4.0mA, V	CC = VCCmin		0.45	V
v (1)	Output High Voltage	$I_{OH} = -2.0 \text{mA}, V$	V _{CC} = V _{CCmin}	0.85V _{CCQ}		V
V _{OH} ⁽¹⁾	Output High Voltage	$I_{OH} = -100\mu A$, $V_{CC} = V_{CCmin}$		V _{CCQ} - 0.4		V
V _{ID}	Identification Voltage			11.5	12.5	V
V _{LKO} ⁽¹⁾	Program/Erase Lockout Supply Voltage			1.8	2.3	V

Note: 1. Sampled only, not 100% tested.

Figure 9. Read Mode AC Waveforms tAVAV A0-A21 VALID - tAVQV tAXQX Ē - tELQV tEHQX tEHQZ tELQX - $\bar{\mathsf{G}}$ - tGLQX tGHQX - tGLQV tGHQZ 🕂 DQ0-DQ7/ DQ8-DQ15 VALID AI06699

Table 10. Read AC Characteristics

Comple ed	A 14	Alt Parameter		-liti		Unit			
Symbol	Alt	Parameter	Test Condition		70	90	100	120	Unit
t _{AVAV}	t _{RC}	Address Valid to Next Address Valid	$\overline{E} = V_{IL},$ $\overline{G} = V_{IL}$	Min	70	90	100	120	ns
t _{AVQV}	t _{ACC}	Address Valid to Output Valid	Address Valid to Output Valid $\frac{\overline{E} = V_{IL}}{\overline{G} = V_{IL}}$ Max		70	90	100	120	ns
t _{ELQX} (1)	t _{LZ}	Chip Enable Low to Output Transition	G = V _{IL}	Min	0	0	0	0	ns
t _{ELQV}	t _{CE}	Chip Enable Low to Output Valid	$\overline{G} = V_{IL}$	Max	70	90	100	120	ns
t _{GLQX} (1)	t _{OLZ}	Output Enable Low to Output Transition	$\overline{E} = V_{IL}$	Min	0	0	0	0	ns
t _{GLQV}	t _{OE}	Output Enable Low to Output Valid	E = V _{IL}	Max	30	35	35	50	ns
t _{EHQZ} (1)	t _{HZ}	Chip Enable High to Output Hi-Z	G = V _{IL}	Max	25	30	30	30	ns
t _{GHQZ} (1)	t _{DF}	Output Enable High to Output Hi-Z	E = V _{IL}	Max	25	30	30	30	ns
t _{EHQX} t _{GHQX} t _{AXQX}	t _{OH}	Chip Enable, Output Enable or Address Transition to Output Transition		Min	0	0	0	0	ns

Note: 1. Sampled only, not 100% tested.

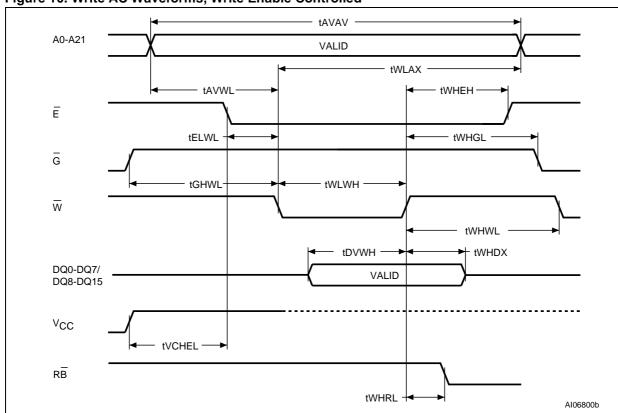


Figure 10. Write AC Waveforms, Write Enable Controlled

Note: 1. $R\overline{B}$ concerns the M29W461DU only.

Table 11. Write AC Characteristics, Write Enable Controlled

Symbol Alt		Parameter		M29V	/641D		Unit	
Symbol	Symbol Att Tarameter				90	100	120	Oill
t _{AVAV}	t _{WC}	Address Valid to Next Address Valid	Min	70	90	100	120	ns
tELWL	tcs	Chip Enable Low to Write Enable Low	Min	0	0	0	0	ns
t _{WLWH}	t _{WP}	Write Enable Low to Write Enable High	Min	35	35	35	50	ns
t _{DVWH}	t _{DS}	Input Valid to Write Enable High	Min	45	45	45	50	ns
t _{WHDX}	t _{DH}	Write Enable High to Input Transition	Min	0	0	0	0	ns
twheh	tcH	Write Enable High to Chip Enable High	Min	0	0	0	0	ns
twhwL	twph	Write Enable High to Write Enable Low	Min	30	30	30	30	ns
t _{AVWL}	t _{AS}	Address Valid to Write Enable Low	Min	0	0	0	0	ns
t _{WLAX}	t _{AH}	Write Enable Low to Address Transition	Min	45	45	45	50	ns
tGHWL		Output Enable High to Write Enable Low	Min	0	0	0	0	ns
twhgL	toeh	Write Enable High to Output Enable Low	Min	0	0	0	0	ns
t _{WHRL} ⁽¹⁾	t _{BUSY}	Program/Erase Valid to RB Low	Max	90	90	90	90	ns
tvchel	t _{VCS}	V _{CC} High to Chip Enable Low	Min	50	50	50	50	μs

Note: 1. This timing concerns the M29W461DU only.

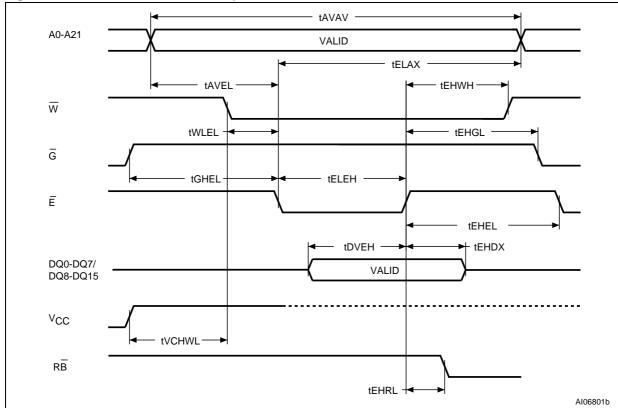


Figure 11. Write AC Waveforms, Chip Enable Controlled

Note: 1. $R\overline{B}$ concerns the M29W461DU only.

Table 12. Write AC Characteristics, Chip Enable Controlled

Cumbal	Alt	Parameter			M29V	/641D		I Imit
Symbol	ymbol Ait lataneter			70	90	100	120	Unit
t _{AVAV}	t _{WC}	Address Valid to Next Address Valid	Min	70	90	100	120	ns
tWLEL	tws	Write Enable Low to Chip Enable Low	Min	0	0	0	0	ns
t _{ELEH}	t _{CP}	Chip Enable Low to Chip Enable High	Min	45	45	45	50	ns
t _{DVEH}	t _{DS}	Input Valid to Chip Enable High	Min	45	45	45	50	ns
t _{EHDX}	t _{DH}	Chip Enable High to Input Transition	Min	0	0	0	0	ns
tehwh	t _{WH}	Chip Enable High to Write Enable High	Min	0	0	0	0	ns
t _{EHEL}	t _{CPH}	Chip Enable High to Chip Enable Low	Min	30	30	30	30	ns
t _{AVEL}	t _{AS}	Address Valid to Chip Enable Low	Min	0	0	0	0	ns
t _{ELAX}	t _{AH}	Chip Enable Low to Address Transition	Min	45	45	45	50	ns
t _{GHEL}		Output Enable High Chip Enable Low	Min	0	0	0	0	ns
tEHGL	toeh	Chip Enable High to Output Enable Low	Min	0	0	0	0	ns
t _{EHRL} (1)	tBUSY	Program/Erase Valid to RB Low	Max	90	90	90	90	ns
tvchwl	t _{VCS}	V _{CC} High to Write Enable Low	Min	50	50	50	50	μs

Note: 1. This timing concerns the M29W461DU only.

 \overline{W} , \overline{E} , \overline{G} tPHWL, tPHEL, tPHGL $R\overline{B}$ ◆ tRHWL, tRHEL, tRHGL tPLPX -RP tPHPHH tPLYH AI06802b

Figure 12. Reset/Block Temporary Unprotect AC Waveforms

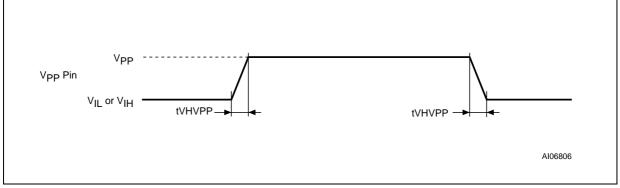
Note: 1. RB concerns the M29W461DU only.

Table 13. Reset/Block Temporary Unprotect AC Characteristics

Symbol Alt		Parameter			M29W641D				
Syllibol	raianietei			70	90	100	120	Unit	
t _{PHWL} (1) t _{PHEL} t _{PHGL} (1)	t _{RH}	RP High to Write Enable Low, Chip Enable Low, Output Enable Low	Min	50	50	50	50	ns	
t _{RHWL} (1, 2) t _{RHEL} (1, 2) t _{RHGL} (1, 2)	t _{RB}	B High to Write Enable Low, Chip Enable Low, utput Enable Low		0	0	0	0	ns	
tpLYH	t _{READY}	RP Low to Read Mode	Max	50	50	50	50	μs	
t _{PLPX}	t _{RP}	RP Pulse Width	Min	500	500	500	500	ns	
t _{PHPHH} ⁽¹⁾	t _{VIDR}	RP Rise Time to V _{ID}		500	500	500	500	ns	
t _{VHVPP} (1)		V _{PP} Rise and Fall Time	Min	250	250	250	250	ns	

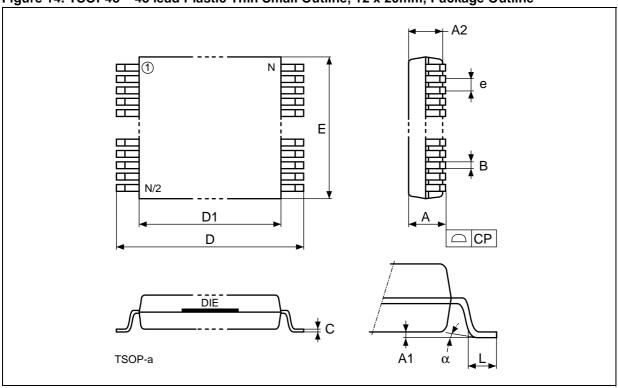
Note: 1. Sampled only, not 100% tested.
2. These timings concern the M29W461DU only.

Figure 13. Accelerated Program Timing Waveforms



PACKAGE MECHANICAL

Figure 14. TSOP48 - 48 lead Plastic Thin Small Outline, 12 x 20mm, Package Outline



Note: Drawing is not to scale.

Table 14. TSOP48 – 48 lead Plastic Thin Small Outline, 12 x 20mm, Package Mechanical Data

Cumbal		millimeters			inches	
Symbol	Тур	Min	Max	Тур	Min	Max
Α			1.200			0.0472
A1	0.100	0.050	0.150	0.0039	0.0020	0.0059
A2	1.000	0.950	1.050	0.0394	0.0374	0.0413
В		0.170	0.270		0.0067	0.0106
С		0.100	0.210		0.0039	0.0083
CP			0.100			0.0039
D		19.800	20.200		0.7795	0.7953
D1		18.300	18.500		0.7205	0.7283
е	0.500	_	_	0.0197	_	_
E		11.900	12.100		0.4685	0.4764
L		0.500	0.700		0.0197	0.0276
alfa		0	5		0	5
N	48			48		

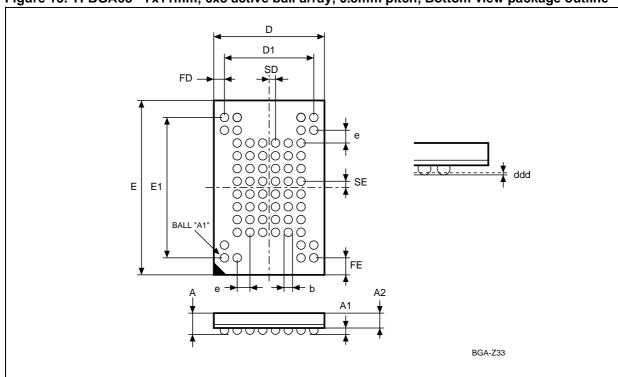


Figure 15. TFBGA63 - 7x11mm, 6x8 active ball array, 0.8mm pitch, Bottom view package outline

Note: Drawing is not to scale.

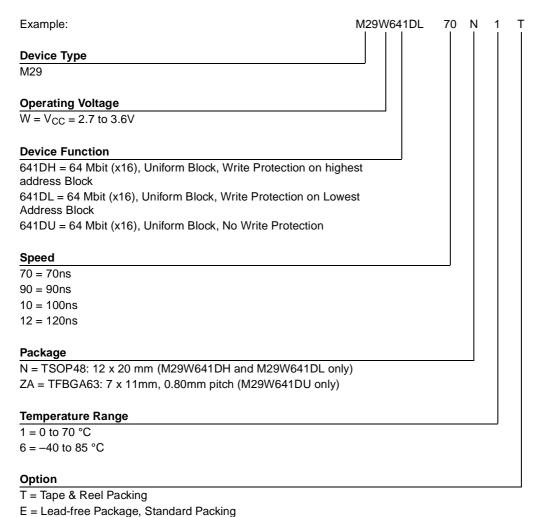
Table 15. TFBGA63 - 7x11mm, 6x8 active ball array, 0.8mm pitch, Package Mechanical Data

Symbol		millimeters		inches		
Symbol	Тур	Min	Max	Тур	Min	Max
А			1.200			0.0472
A1		0.250			0.0098	
A2			0.900			0.0354
b		0.350	0.450		0.0138	0.0177
D	7.000	6.900	7.100	0.2756	0.2717	0.2795
D1	5.600	_	_	0.2205	_	_
ddd	-	_	0.100	_	-	0.0039
Е	11.000	10.900	11.100	0.4331	0.4291	0.4370
E1	8.800	-	-	0.3465	-	_
е	0.800	_	-	0.0315	-	_
FD	0.700	_	-	0.0276	-	_
FE	1.100	-	-	0.0433	-	_
SD	0.400	-	-	0.0157	-	_
SE	0.400	-	-	0.0157	-	-

PART NUMBERING

Table 16. Ordering Information Scheme

F = Lead-free Package, Tape & Reel Packing



Note: This product is also available with the Extended Block factory locked. For further details and ordering information contact your nearest ST sales office.

Devices are shipped from the factory with the memory content bits erased to 1. For a list of available options (Speed, Package, etc.) or for further information on any aspect of this device, please contact your nearest ST Sales Office.

APPENDIX A. BLOCK ADDRESSES

Table 17. Block Addresses

Block	KWords	Protection Block Group	Address Range
0	32		000000h-007FFh ⁽¹⁾
1	32	Protection Group	008000h-00FFFFh
2	32		010000h-017FFFh
3	32		018000h-01FFFFh
4	32		020000h-027FFFh
5	32	Drotootion Crown	028000h-02FFFFh
6	32	Protection Group	030000h-037FFFh
7	32		038000h-03FFFFh
8	32		040000h-047FFFh
9	32	Protection Croup	048000h-04FFFFh
10	32	Protection Group	050000h-057FFFh
11	32		058000h-05FFFFh
12	32		060000h-067FFFh
13	32	Drotootion Crown	068000h-06FFFFh
14	32	Protection Group	070000h-077FFFh
15	32		078000h-07FFFFh
16	32		080000h-087FFFh
17	32	Protection Croup	088000h-08FFFFh
18	32	Protection Group	090000h-097FFh
19	32		098000h-09FFFFh
20	32		0A0000h-0A7FFFh
21	32	Protection Croup	0A8000h-0AFFFFh
22	32	Protection Group	0B0000h-0B7FFFh
23	32		0B8000h-0BFFFFh
24	32		0C0000h-0C7FFFh
25	32	Drotaction Croup	0C8000h-0CFFFFh
26	32	Protection Group	0D0000h-0D7FFFh
27	32	7	0D8000h-0DFFFFh
28	32		0E0000h-0E7FFFh
29	32	Protection Croup	0E8000h-0EFFFFh
30	32	Protection Group	0F0000h-0F7FFFh
31	32		0F8000h-0FFFFh

Block	KWords	Protection Block Group	Address Range
32	32		100000h-107FFFh
33	32	Protection Group	108000h-10FFFFh
34	32		110000h-117FFFh
35	32		118000h-11FFFFh
36	32		120000h-127FFFh
37	32	Protection Croup	128000h-12FFFFh
38	32	Protection Group	130000h-137FFFh
39	32		138000h-13FFFFh
40	32		140000h-147FFFh
41	32	Protection Group	148000h-14FFFFh
42	32		150000h-157FFFh
43	32		158000h-15FFFFh
44	32		160000h-167FFFh
45	32	Brotaction Croup	168000h-16FFFFh
46	32	Protection Group	170000h-177FFFh
47	32		178000h-17FFFFh
48	32	Drada ation Consum	180000h-187FFFh
49	32		188000h-18FFFFh
50	32	Protection Group	190000h-197FFFh
51	32		198000h-19FFFFh
52	32		1A0000h-1A7FFFh
53	32	Protection Group	1A8000h-1AFFFFh
54	32	Flotection Group	1B0000h-1B7FFFh
55	32		1B8000h-1BFFFFh
56	32		1C0000h-1C7FFFh
57	32	Protection Group	1C8000h-1CFFFFh
58	32	Frotection Group	1D0000h-1D7FFFh
59	32		1D8000h-1DFFFFh
60	32		1E0000h-1E7FFFh
61	32	Brotaction Croup	1E8000h-1EFFFFh
62	32	Protection Group	1F0000h-1F7FFFh
63	32		1F8000h-1FFFFFh
64	32		200000h–207FFFh
65	32	Protection Crown	208000h-20FFFFh
66	32	Protection Group	210000h–217FFFh
67	32		218000h-21FFFFh

Block	KWords	Protection Block Group	Address Range
68	32		220000h-227FFFh
69	32	Protection Group	228000h-22FFFFh
70	32	Protection Group	230000h-237FFFh
71	32		238000h-23FFFFh
72	32		240000h-247FFFh
73	32	Protection Croup	248000h-24FFFh
74	32	Protection Group	250000h-257FFFh
75	32		258000h-25FFFh
76	32		260000h-267FFFh
77	32	Protection Croup	268000h-26FFFh
78	32	Protection Group	270000h-277FFFh
79	32		278000h-27FFFh
80	32		280000h-287FFFh
81	32] Bustantia o Ouron	288000h-28FFFFh
82	32	Protection Group	290000h-297FFFh
83	32		298000h-29FFFh
84	32	Destantian Conve	2A0000h-2A7FFFh
85	32		2A8000h-2AFFFFh
86	32	Protection Group	2B0000h-2B7FFFh
87	32		2B8000h-2BFFFFh
88	32		2C0000h-2C7FFFh
89	32	Protection Croup	2C8000h-2CFFFFh
90	32	Protection Group	2D0000h-2D7FFFh
91	32		2D8000h-2DFFFFh
92	32		2E0000h-2E7FFh
93	32	Protection Group	2E8000h-2EFFFFh
94	32	Frotection Group	2F0000h-2F7FFFh
95	32		2F8000h-2FFFFh
96	32		300000h-307FFFh
97	32	Protection Group	308000h-30FFFFh
98	32	Protection Group	310000h-317FFFh
99	32		318000h-31FFFFh
100	32		320000h-327FFFh
101	32	Protection Group	328000h-32FFFFh
102	32	Frotection Group	330000h-337FFFh
103	32		338000h-33FFFFh

Block	KWords	Protection Block Group	Address Range
104	32		340000h-347FFFh
105	32	Protection Group	348000h-34FFFFh
106	32	Protection Group	350000h-357FFFh
107	32		358000h-35FFFFh
108	32		360000h-367FFFh
109	32	Protection Group	368000h-36FFFFh
110	32	Protection Group	370000h-377FFFh
111	32		378000h-37FFFFh
112	32		380000h-387FFFh
113	32	Protection Group	388000h-38FFFFh
114	32	Frotection Group	390000h-397FFFh
115	32		398000h-39FFFFh
116	32		3A0000h-3A7FFFh
117	32	Protection Croup	3A8000h-3AFFFFh
118	32	Protection Group	3B0000h-3B7FFFh
119	32		3B8000h-3BFFFFh
120	32		3C0000h-3C7FFFh
121	32	Protoction Crown	3C8000h-3CFFFFh
122	32	Protection Group	3D0000h-3D7FFFh
123	32		3D8000h-3DFFFFh
124	32		3E0000h-3E7FFFh
125	32	Posterific C	3E8000h-3EFFFFh
126	32	Protection Group	3F0000h-3F7FFFh
127	32		3F8000h-3FFFFFh

Note: 1. Used as the Extended Block Addresses in Extended Block mode.

APPENDIX B. COMMON FLASH INTERFACE (CFI)

The Common Flash Interface is a JEDEC approved, standardized data structure that can be read from the Flash memory device. It allows a system software to query the device to determine various electrical and timing parameters, density information and functions supported by the memory. The system can interface easily with the device, enabling the software to upgrade itself when necessary.

When the CFI Query Command is issued the device enters CFI Query mode and the data structure is read from the memory. Table 18 to Table 23 show the addresses used to retrieve the data.

The CFI data structure also contains a security area where a 64 bit unique security number is written (see Table 23, Security Code Area). This area can be accessed only in Read mode by the final user. It is impossible to change the security number after it has been written by ST.

Table 18. Query Structure Overview

Address	Sub-section Name	Description
10h	CFI Query Identification String	Command set ID and algorithm data offset
1Bh	System Interface Information	Device timing & voltage information
27h	Device Geometry Definition	Flash device layout
40h	Primary Algorithm-specific Extended Query table	Additional information specific to the Primary Algorithm (optional)
61h	Security Code Area	64 bit unique device number

Note: Query data are always presented on the lowest order data outputs.

Table 19. CFI Query Identification String

Address	Data	Description	Value
10h	0051h		"Q"
11h	0052h	Query Unique ASCII String "QRY"	"R"
12h	0059h		"Y"
13h	0002h	Primary Algorithm Command Set and Control Interface ID code 16 bit	AMD
14h	0000h	ID code defining a specific algorithm	Compatible
15h	0040h	Addraga for Primary Algarithm autonded Quary table (and Table 22)	P = 40h
16h	0000h	Address for Primary Algorithm extended Query table (see Table 22)	F = 40II
17h	0000h	Alternate Vendor Command Set and Control Interface ID Code second	NA
18h	0000h	vendor - specified algorithm supported	INA
19h	0000h	Address for Alternate Algorithm extended Query table	NA
1Ah	0000h		INA

Note: Query data are always presented on the lowest order data outputs (DQ7-DQ0) only. DQ8-DQ15 are '0'.

Table 20. CFI Query System Interface Information

Address	Data	Description	Value
1Bh	0027h	V _{CC} Logic Supply Minimum Program/Erase voltage bit 7 to 4 BCD value in volts bit 3 to 0 BCD value in 100 mV	2.7V
1Ch	0036h	V _{CC} Logic Supply Maximum Program/Erase voltage bit 7 to 4 BCD value in volts bit 3 to 0 BCD value in 100 mV	3.6V
1Dh	00B5h	V _{PP} [Programming] Supply Minimum Program/Erase voltage bit 7 to 4 HEX value in volts bit 3 to 0 BCD value in 100 mV	11.5V
1Eh	00C5h	V _{PP} [Programming] Supply Maximum Program/Erase voltage bit 7 to 4 HEX value in volts bit 3 to 0 BCD value in 100 mV	12.5V
1Fh	0004h	Typical timeout per single word program = 2 ⁿ μs	16µs
20h	0000h	Typical timeout for minimum size write buffer program = 2 ⁿ μs	NA
21h	000Ah	Typical timeout per individual block erase = 2 ⁿ ms	1s
22h	0000h	Typical timeout for full chip erase = 2 ⁿ ms	NA
23h	0004h	Maximum timeout for word program = 2 ⁿ times typical	256 µs
24h	0000h	Maximum timeout for write buffer program = 2 ⁿ times typical	NA
25h	0003h	Maximum timeout per individual block erase = 2 ⁿ times typical	8 s
26h	0000h	Maximum timeout for chip erase = 2 ⁿ times typical	NA

Table 21. Device Geometry Definition

Address	Data	Description	Value
27h	0017h	Device Size = 2 ⁿ in number of bytes	8 MByte
28h 29h	0001h 0000h	Flash Device Interface Code description	x16 Async.
2Ah 2Bh	0000h 0000h	Maximum number of bytes in multi-byte program or page = 2 ⁿ	NA
2Ch	0001h	Number of Erase Block Regions. It specifies the number of regions containing contiguous Erase Blocks of the same size.	1
2Dh 2Eh	007Fh 0000h	Region 1 Information Number of identical size erase block = 007Fh+1	128
2Fh 30h	0000h 0001h	Region 1 Information Block size in Region 1 = 0100h * 256 byte	64 KByte

Table 22. Primary Algorithm-Specific Extended Query Table

Address	Data	Data Description	
40h	0050h		"P"
41h	0052h	Primary Algorithm extended Query table unique ASCII string "PRI"	
42h	0049h		
43h	0031h	Major version number, ASCII	"1"
44h	0030h	Minor version number, ASCII	"0"
45h	0000h	Address Sensitive Unlock (bits 1 to 0) 00 = required, 01= not required Silicon Revision Number (bits 7 to 2)	
46h	0002h	Erase Suspend 00 = not supported, 01 = Read only, 02 = Read and Write	
47h	0004h	Block Protection 00 = not supported, x = number of blocks per protection group	
48h	0001h	Temporary Block Unprotect 00 = not supported, 01 = supported	
49h	0004h	Block Protect /Unprotect 04 = M29W400B	
4Ah	0000h	Simultaneous Operations, 00 = not supported	
4Bh	0000h	Burst Mode, 00 = not supported, 01 = supported	
4Ch	0000h	Page Mode, 00 = not supported, 01 = 4 page word, 02 = 8 page word	
4Dh	00B5h	V _{PP} Supply Minimum Program/Erase voltage bit 7 to 4 HEX value in volts bit 3 to 0 BCD value in 100 mV	
4Eh	00C5h	V _{PP} Supply Maximum Program/Erase voltage bit 7 to 4 HEX value in volts bit 3 to 0 BCD value in 100 mV	

Table 23. Security Code Area

Address	Data	Description
61h	XXXX	
62h	XXXX	C4 hitu unique device number
63h	XXXX	64 bit: unique device number
64h	XXXX	

APPENDIX C. EXTENDED MEMORY BLOCK

The M29W641D has an extra block, the Extended Block, that can be accessed using a dedicated command.

This Extended Block is 32 KWords. It is used as a security block (to provide a permanent security identification number) or to store additional information

The Extended Block is either Factory Locked or Customer Lockable, its status is indicated by bit DQ7. This bit is permanently set to either '1' or '0' at the factory and cannot be changed. When set to '1', it indicates that the device is factory locked and the Extended Block is protected. When set to '0', it indicates that the device is customer lockable and the Extended Block is unprotected. Bit DQ7 being permanently locked to either '1' or '0' is another security feature which ensures that a customer lockable device cannot be used instead of a factory locked one.

Bit DQ7 is the most significant bit in the Extended Block Verify Code and a specific procedure must be followed to read it. See "Extended Memory Block Verify Code" in Table 2, Bus Operations, for details of how to read bit DQ7.

The Extended Block can only be accessed when the device is in Extended Block mode. For details of how the Extended Block mode is entered and exited, refer to the Enter Extended Block Command and Exit Extended Block Command paragraphs, and to Table 3, "Commands".

Factory Locked Extended Block

In devices where the Extended Block is factory locked, the Security Identification Number is written to the Extended Block address space (see Table 24, Extended Block Address and Data) in the factory. The DQ7 bit is set to '1' and the Extended Block cannot be unprotected.

Customer Lockable Extended Block

A device where the Extended Block is customer lockable is delivered with the DQ7 bit set to '0' and the Extended Block unprotected. It is up to the customer to program and protect the Extended Block but care must be taken because the protection of the Extended Block is not reversible.

There are two ways of protecting the Extended Block:

- Issue the Enter Extended Block command to place the device in Extended Block mode, then use the In-System Technique (refer to Appendix D, In-System Technique and to the corresponding flowcharts, Figures 18 and 19, for a detailed explanation of the technique).
- Issue the Enter Extended Block command to place the device in Extended Block mode, then use the Programmer Technique (refer to Appendix D, Programmer Technique and to the corresponding flowcharts, Figures 16 and 17, for a detailed explanation of the technique).

Once the Extended Block is programmed and protected, the Exit Extended Block command must be issued to exit the Extended Block mode and return the device to Read mode.

Table 24. Extended Block Address and Data

Device	Address ⁽¹⁾	Data		
	x16	Factory Locked	Customer Lockable	
M29W641D	000000h-000007h	Security Identification Number	Determined by Customer	
	000008h-007FFFh	Unavailable	Determined by Castomer	

Note: 1. See Table 17, Block Addresses.

APPENDIX D. BLOCK PROTECTION

Block protection can be used to prevent any operation from modifying the data stored in the memory. Once protected, Program and Erase operations within the protected group fail to change the data.

There are three techniques that can be used to control Block Protection, these are the Programmer technique, the In-System technique and Temporary Unprotection. Temporary Unprotection is controlled by the Reset/Block Temporary Unprotection pin, RP; this is described in the Signal Descriptions section.

Programmer Technique

The Programmer technique uses high (V_{ID}) voltage levels on some of the bus pins. These cannot be achieved using a standard microprocessor bus, therefore the technique is recommended only for use in Programming Equipment.

To protect a group of blocks follow the flowchart in Figure 16, Programmer Equipment Group Protect Flowchart. To unprotect the whole chip it is necessary to protect all of the groups first, then all groups can be unprotected at the same time. To unprotect the chip follow Figure 17, Programmer Equipment Chip Unprotect Flowchart. Table 25, Programmer Technique Bus Operations, gives a summary of each operation.

The timing on these flowcharts is critical. Care should be taken to ensure that, where a pause is

specified, it is followed as closely as possible. Do not abort the procedure before reaching the end. Chip Unprotect can take several seconds and a user message should be provided to show that the operation is progressing.

In-System Technique

The In-System technique requires a high voltage level on the Reset/Blocks Temporary Unprotect pin, RP. This can be achieved without violating the maximum ratings of the components on the microprocessor bus, therefore this technique is suitable for use after the memory has been fitted to the system.

To protect a group of blocks follow the flowchart in Figure 18, In-System Equipment Group Protect Flowchart. To unprotect the whole chip it is necessary to protect all of the groups first, then all the groups can be unprotected at the same time. To unprotect the chip follow Figure 19, In-System Equipment Chip Unprotect Flowchart.

The timing on these flowcharts is critical. Care should be taken to ensure that, where a pause is specified, it is followed as closely as possible. Do not allow the microprocessor to service interrupts that will upset the timing and do not abort the procedure before reaching the end. Chip Unprotect can take several seconds and a user message should be provided to show that the operation is progressing.

Table 25. Programmer Technique Bus Operations

Operation	Ē	G	w	Address Inputs A0-A21	Data Inputs/Outputs DQ15-DQ0
Block (Group) Protect ⁽¹⁾	VIL	V _{ID}	V _{IL} Pulse	A9 = V _{ID} , A12-A21 Block Address Others = X	Х
Chip Unprotect	V _{ID}	V _{ID}	V _{IL} Pulse	$A9 = V_{ID}, A12 = V_{IH}, A15 = V_{IH}$ $Others = X$	х
Block (Group) Protection Verify	V _{IL}	V _{IL}	V _{IH}	$A0 = V_{IL}, A1 = V_{IH}, A6 = V_{IL}, A9 = V_{ID}, \\ A12\text{-}A21 \ Block \ Address} \\ Others = X$	Pass = XX01h Retry = XX00h
Block (Group) Unprotection Verify	V _{IL}	V _{IL}	V _{IH}	A0 = V _{IL} , A1 = V _{IH} , A6 = V _{IH} , A9 = V _{ID} , A12-A21 Block Address Others = X	Retry = XX01h Pass = XX00h

Note: 1. Block Protection Groups are shown in Appendix A, Tables 17.

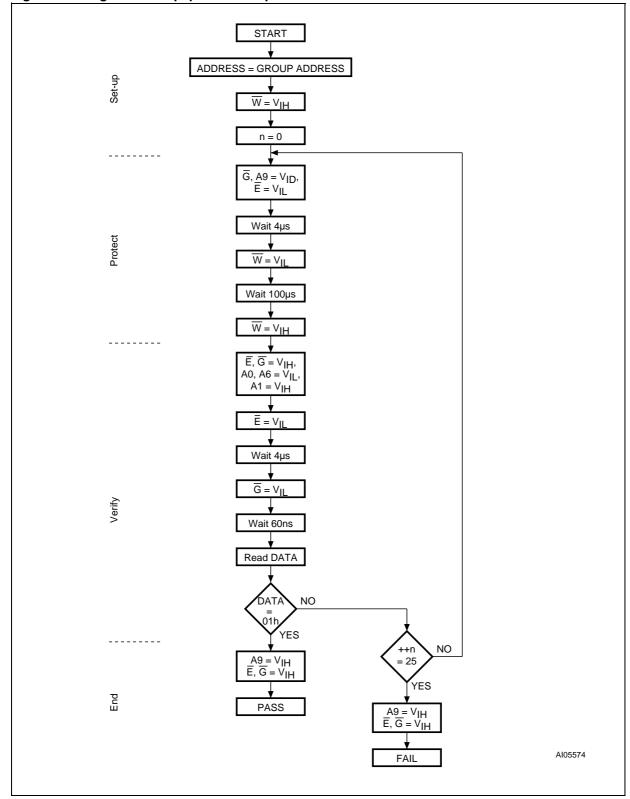


Figure 16. Programmer Equipment Group Protect Flowchart

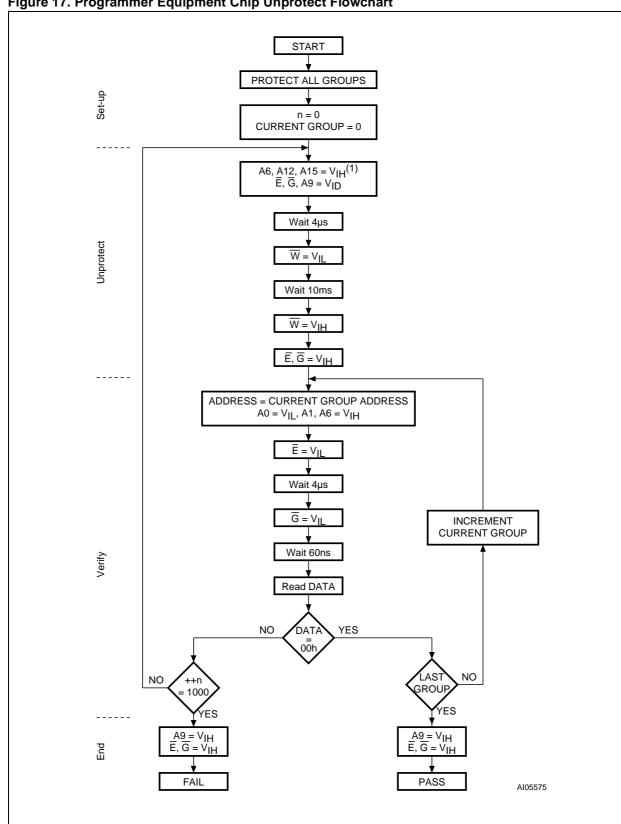


Figure 17. Programmer Equipment Chip Unprotect Flowchart

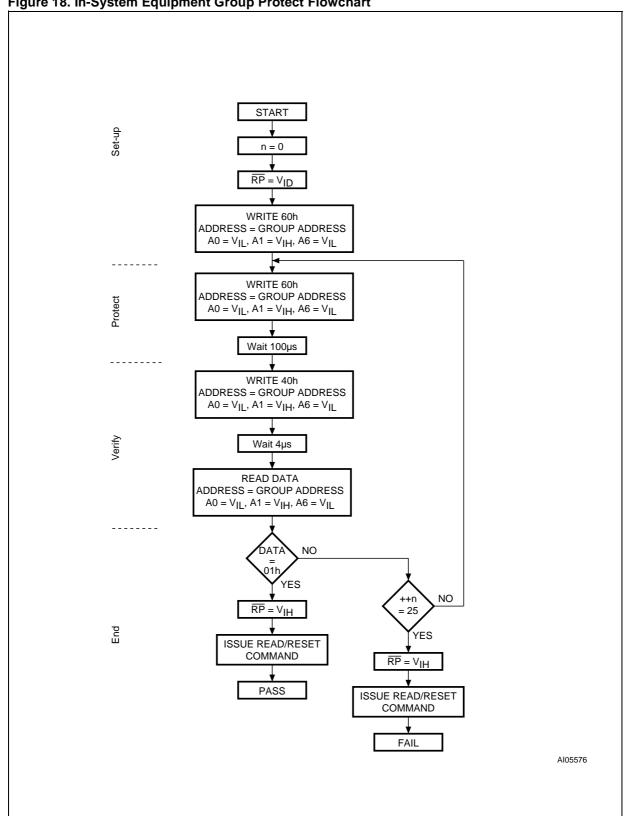


Figure 18. In-System Equipment Group Protect Flowchart

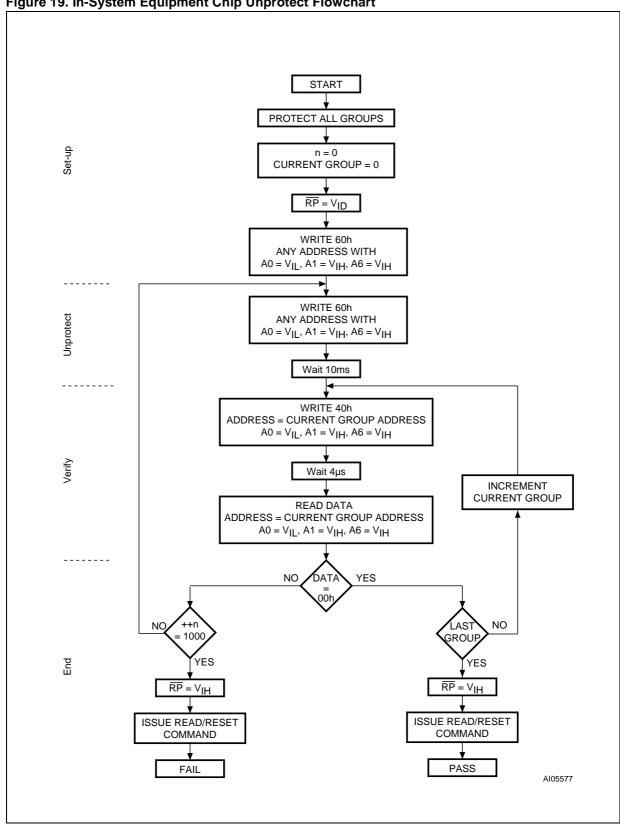


Figure 19. In-System Equipment Chip Unprotect Flowchart

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REVISION HISTORY

Table 26. Document Revision History

Date	Version	Revision Details
30-Apr-2002	-01	Document released
05-Sep-2002	1.1	When in Extended Block mode, the block at the boot block address can be used as OTP. Data Toggle Flow chart corrected. Double Word Program Time (typ) changed to 20s. Revision numbering modified: a minor revision will be indicated by incrementing the digit after the dot, and a major revision, by incrementing the digit before the dot (revision version 01 equals 1.0).
8-Apr-2003	2.0	New Part Numbers added. 100ns and 120ns Speed Classes added. TFBGA63 package added. V _{IO} removed from and V _{CCQ} added to Table 6, Absolute Maximum Ratings. V _{CCQ} added to Table 7, Operating and AC Measurement Conditions. Ready/Busy pin (TFBGA63 package) added to the signals (concerns M29W641DU only). Figure 7, AC Measurement I/O Waveform, and Figure 8, AC Measurement Load Circuit, modified. Unlock Bypass Commands clarified and V _{CCQ} description specified in SIGNAL DESCRIPTIONS section. Test Conditions modified for I _{LI} , I _{LO} , V _{IL} , V _{IH} , V _{OL} and V _{OH} parameters in Table 9, DC Characteristics, and V _{IL} , V _{IH} , V _{OL} and V _{OH} parameters corrected. t _{WLWH} , t _{DVWH} , t _{WLAX} , t _{WHRL} parameters modified for 90ns speed class in Table 11, Write AC Characteristics, Write Enable Controlled. t _{ELEH} , t _{DVEH} , t _{ELAX} and t _{EHRL} parameters modified for 90ns speed class in Table 12, Write AC Characteristics, Chip Enable Controlled. t _{PLYH} parameter added to Table 13, Reset/Block Temporary Unprotect AC Characteristics. Data and Value modified for address 2Dh, and Data modified for address 30h in Table 21, Device Geometry Definition. Description modified at address offset 4Eh in Table 22. Data Retention and Erase Suspend Latency Time parameters added to Table 6, Program, Erase Times and Program, Erase Endurance Cycles, and Typical after 100k W/E Cycles column removed. I _{ID} (Identification) current removed from Table 9, DC Characteristics. Lead-free package options E and F added to Table 16, Ordering Information Scheme. Appendix C, EXTENDED MEMORY BLOCK, added. V _{SS} pin connection to ground clarified. Auto Select Command is used to read the Extended Memory Block. Note added to Table 16, Ordering Information Scheme.

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